### SN5422, SN54LS22, SN54S22, SN7422, SN74LS22, SN74S22 SDLS080 DUAL 4-INPUT POSITIVE-NAND GATES WITH OPEN-COLLECTOR OUTPUTS December 1983 – REVISED MARCH 1988

- Package Options Include Plastic "Small Outline" Packages, Ceramic Chlp Carriers and Flat Packages, and Plastic and Ceramic DIPs
- Dependable Texas Instruments Quality and Reliability

#### description

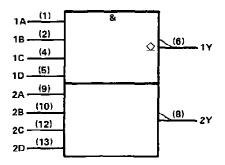
These devices contain two independent 4-input NAND gates. The open-collector outputs require pull-up resistors to perform correctly. They may be connected to other open-collector outputs to implement active-low wired-OR or active-high wired-AND functions. Open-collector devices are often used to generate higher VOH levels.

The SN5422, SN54LS22 and SN54S22 are characterized for operation over the full military temperature range of -55 °C to 125 °C. The SN7422, SN74LS22, and SN74S22 are characterized for operation from 0 °C to 70 °C.

#### FUNCTION TABLE (each gate)

[		UTS		OUTPUT
A	8	с	D	Y
н	Н	н	н	L
L	х	х	- X	H
Х	L	х	X	н
х	х	L	- ×	н
х	х	х	L	н

#### logic symbol<sup>†</sup>



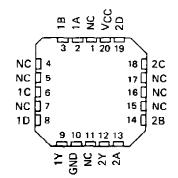
<sup>†</sup> This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

Pin numbers shown are for D, J, N, and W packages.

PRODUCTION DATA documents contain information current as of publication data. Products conform to specifications por the terms of Texas Instruments standard warrenty. Production processing does not necessarily include testing of all parameters. SN5422, SN54LS22, SN54S22...J OR W PACKAGE SN7422...N PACKAGE SN74LS22, SN74S22...D OR N PACKAGE (TOP VIEW)

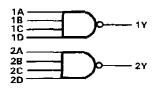
1A [] 1B []2 NC []3 1C []4 1D []5	U 14 UCC 13 2D 12 2C 11 NC 10 2B
	9 2A 8 2Y
	8[J] 2 Y

\$N54LS22, \$N54S22 ... FK PACKAGE (TOP VIEW)



NC-No internal connection

#### logic diagram



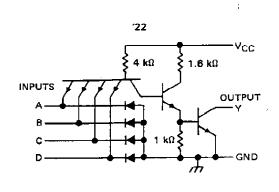
### positive logic

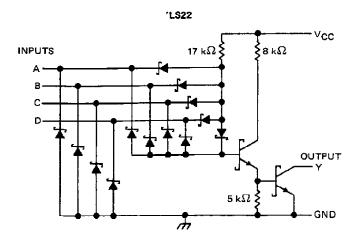
$$Y = \overline{A \cdot B \cdot C \cdot D}$$
 or  $Y = \overline{A} + \overline{B} + \overline{C} + \overline{D}$ 

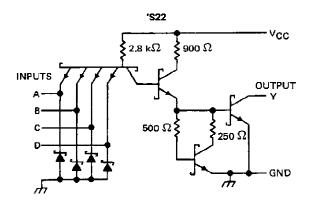
TEXAS V INSTRUMENTS

## SN5422, SN54LS22, SN54S22, SN7422, SN74LS22, SN74S22 DUAL 4-INPUT POSITIVE-NAND GATES WITH OPEN-COLLECTOR OUTPUTS

schematics (each gate)







Resistor values shown are nominal.

## absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, VCC (See Note 1)		7 V
Input voltage: '22, 'S22		5.5 V
LS22		7V
Operating free-air temperature range:	SN54′	-55°C to 125°C
	SN74'	
Storage temperature range		-65°C to 150°C

NOTE 1: Voltage values are with respect to network ground terminal.

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# SN5422, SN7422 DUAL 4-INPUT POSITIVE-NAND GATES WITH OPEN-COLLECTOR OUTPUTS

recommended operating conditions

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	s	SN5422			SN7422			
	MIN	NOM	MAX	MIN	NOM	MAX	UNIT	
V <sub>CC</sub> Supply voltage	4.5	5	5.5	4.75	5	5.25	v	
VIH High-level input voltage	2			2			V	
VIL Low-level input voltage			0,8			0,8	V	
VOH High-level output voltage			5.5			5.5	V	
IOL Low-level output current			16			16	mA	
TA Operating free-air temperature	- 55		125	0		70	°C	

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

	TEST CONDITIONS <sup>†</sup>	SN5422	SN7422	
PARAMETER	TEST CONDITIONS (	MIN TYP <sup>‡</sup> MAX	MIN TYP <sup>‡</sup> MAX	UNIT
VIK	$V_{CC} = MIN$ , $I_{I} = -12 \text{ mA}$	- 1.5	- 1.5	V
	$V_{CC} = MIN, V_{H_{c}} = 0.8 V, V_{OH} = 5.5 V$		0.25	mA
lон	$V_{CC} = MIN, V_{IL} = 0.7 V, V_{OH} = 5.5 V$	0.25		
VOL	$V_{CC} = MIN$ , $V_{IH} = 2 V$ , $I_{OL} = 16 mA$	0.2 0.4	0.2 0.4	v
lj	$V_{CC} = MAX, V_{ } = 5.5 V$	1	1	mΑ
HH	$V_{CC} = MAX, V_{\parallel} = 2.4 V$	40	40	μA
lμ	$V_{CC} = MAX, V_I = 0.4 V$	- 1.6	-1.6	mΑ
Іссн	$V_{CC} = MAX, V_I = 0$	2 4	2 4	mA
ICCL	$V_{CC} = MAX, V_{I} = 4.5 V$	6 11	6 11	mA

<sup>†</sup>For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions. <sup>‡</sup>All typical values are at  $V_{CC} = 5 V$ ,  $T_A = 25 °C$ .

## switching characteristics, $V_{CC} = 5 V$ , $T_A = 25^{\circ}C$ (see note 2)

PARAMETER	FROM (INPUT)	ΤΟ (ΟυΤΡυΤ)	TEST CON	DITIONS	MIN TYP	МАХ	UNIT
<sup>t</sup> PLH	Апу	Y	$R_{L} = 4 k \Omega,$	CL = 15 pF	35	45	កទ
<sup>t</sup> PHL		·	R <sub>L</sub> = 400 Ω,	CL = 15 pF	8	15	ns

NOTE 2: Load circuits and voltage waveforms are shown in Section 1.

# SN54LS22, SN74LS22 DUAL 4-INPUT POSITIVE-NAND GATES WITH OPEN-COLLECTOR OUTPUTS

### recommended operating conditions

	5	SN54LS	22	SN74LS		22	
	MIN	NOM	MAX	MIN	NOM	MAX	UNIT
VCC Supply voltage	4.5	5	5.5	4.75	5	5.25	v
V1H High-level input voltage	2			2			V
VIL Low-level input voltage			0.7			0.8	V
VOH High-level output voltage			5.5			5.5	V
OL Low-level output current			4			8	mΑ
T <sub>A</sub> Operating free-air temperature	- 55		125	0		70	°C

## electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

		TEST CONDITIONS †		5	SN54LS	22	SN74 LS22			
PARAMETER				MIN	TYP\$	мах	MIN	TYP‡	MAX	UNIT
VIK	V <sub>CC</sub> = MIN,	l <sub>l</sub> = – 18 mA				- 1.5			- 1.5	v
юн	V <sub>CC</sub> = MIN,	V <sub>IL</sub> = MAX,	V <sub>OH</sub> = 5.5 V			0.1			0.1	mА
	Vcc = MIN,	V <sub>IH</sub> = 2 V,	IOL = 4 mA		0.25	0.4		0.25	0.4	v
VOL	V <sub>CC</sub> = MIN,	V <sub>IH</sub> = 2 V,	l <sub>OL</sub> ≖ 8 mA					0.35	0.5	
lj -	V <sub>CC</sub> = MAX,	V <sub>1</sub> = 7 V	· · · · · · · · · · · · · · · · · · ·			0.1			0.1	mA
ін	VCC = MAX.	V) = 2.7 V				20			20	μA
հե	Vcc = MAX,	V <sub>1</sub> = 0.4 V				- 0.4			- 0.4	mΑ
ссн	V <sub>CC</sub> = MAX,	V1 = 0			0.4	0.8		0.4	0.8	mΑ
ICCL	V <sub>CC</sub> = MAX,	V <sub>1</sub> = 4.5 V			1.2	2.2		1.2	2.2	mA

† For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.
‡ All typical values are at V<sub>CC</sub> = 5 V, T<sub>A</sub> = 25°C.

# switching characteristics, VCC = 5 V, TA = $25^{\circ}$ C (see note 2)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	MIN	түр	MAX	UNIT
¢₽Ļ,H	Αηγ	Y	$R_L = 2 k\Omega$ , $C_L = 15 pF$		17	32	ns
<sup>¢</sup> ₽HL	,	•			15	28	n <b>s</b>

NOTE 2: Load circuits and voltage waveforms are shown in Section 1.

# SN54S22, SN74S22 DUAL 4-INPUT POSITIVE-NAND GATES WITH OPEN-COLLECTOR OUTPUTS

		SN54S22			SN74S22		
	MIN	NOM	MAX	MIN	NOM	MAX	UNIT
VCC Supply voltage	4.5	5	5.5	4.75	5	5.25	V
VIH High-level input voltage	2			2			V
VIL Low-level input voltage			0,8			0,8	V
VOH High-level output voltage			5.5			5.5	v
OL Low-level output current			20			20	Αm
FA Operating free-air temperature	- 55		125	0		70	°C

# electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

		SN54822	SN74S22	
PARAMETER	TEST CONDITIONS <sup>†</sup>	MIN TYP <sup>‡</sup> MAX	MIN TYP <sup>‡</sup> MAX	UNIT
VIK	$V_{CC} = MIN, I_I = -18 \text{ mA}$	-1.2	- 1.2	V
	$V_{CC} = MIN, V_{H} = 0.8 V, V_{OH} = 5.5 V$		0.25	mA
ЮН	$V_{CC} = MIN, V_{IL} = 0.7 V, V_{OH} = 5.5 V$	0.25		mA
Vol	$V_{CC} = MIN$ , $V_{IH} = 2 V$ , $I_{OL} = 20 mA$	0.5	0.5	V
<u>-                                    </u>	$V_{CC} = MAX, V_{I} = 5.5 V$	1	1	mA
Iн	$V_{CC} = MAX, V_I = 2.7 V$	50	50	μA
liΓ	$V_{CC} = MAX, V_{\parallel} = 0.5 V$	-2	- 2	mА
ЧССН	$V_{CC} = MAX, V_I = 0$	3 6.6	3 6.6	mA
ICCL	$V_{CC} = MAX, V_{I} = 4.5 V$	10 18	10 18	mA

<sup>†</sup>For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions. <sup>‡</sup>All typical values are at V<sub>CC</sub> = 5 V, T<sub>A</sub> = 25 °C.

## switching characteristics, VCC = 5 V, TA = 25 C (see note 2)

2

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CON		MIN	түр	МАХ	UNIT
tPLH			D	C <sub>1</sub> = 15 pF	2	5	7.5	nş
<sup>t</sup> PHL	Any	∣ <sub>Y</sub> ∟	RL = 280 Ω,	о <u>Г - тар</u> е	2	4.5	7	ns
<sup>t</sup> PLH	<u> </u>		B = 292 ()	0		7.5		ns
<sup>t</sup> PHL			R <sub>L</sub> = 280 Ω,	С <sub>L</sub> - 50 рF		7		ns

NOTE 2: Load circuits and voltage waveforms are shown in Section 1.



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